

PatternPro® *Line of Serial Data Test Instruments*
 Performance • Flexibility • Value



Model 12072 with Model 13020 4 Channel 32Gb/s Bit Error Test System

PSPL's line of **PatternPro®** serial data test instruments enables testing of the latest high-speed serial data standards by addressing critical configuration and cost issues.

The PatternPro line includes **SDG** Pattern Generators and **SDA** Error Detectors that provide high-performance, flexible Bit Error Test solutions. With PatternPro test suites, users are finally able to comprehensively test critical multi-channel product performance parameters such as cross-talk immunity and multi-channel functionality.

Features:

- Available with 1, 2, or 4 channels
- PRBS and user defined patterns
- Independent data on each channel
- Data synchronized PG outputs
- Independently adjustable phase on each channel (both PG & ED)
- Auto ED synchronization to input pattern
- Auto ED phase alignment of clock and data

Benefits:

- **Comprehensive testing of applications such as 4x32 Gb/s DP-QPSK**
 - Independent data on each channel
 - Synchronized and aligned data with independent phase adjustments
 - Live BER monitoring of each channel
- **Flexible configuration and usage**
 - Separate PG and ED usage
 - Configure for number of channels needed

Applications:

- 32Gb/s DP-QPSK testing
- Victim-aggressor cross talk testing
- Simultaneous multi-channel BER testing

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